

TOSHIBA Transistor Silicon NPN Triple Diffused Type

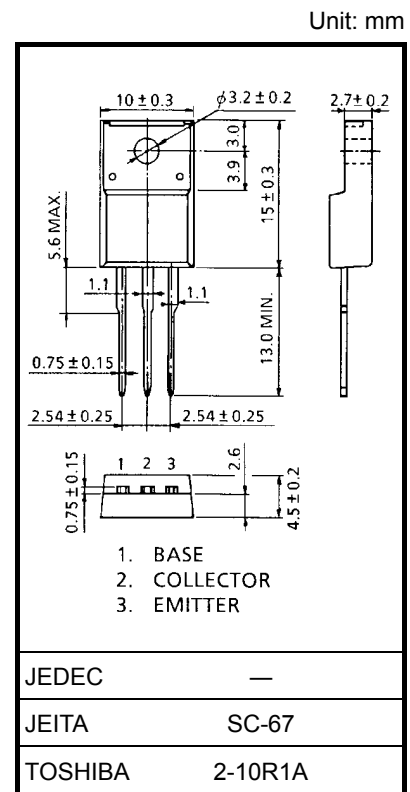
# 2SD2204

High-Power Switching Applications  
Hammer Drive, Pulse Motor Drive Applications

- High DC current gain:  $h_{FE} = 2000$  (min) ( $V_{CE} = 3\text{ V}$ ,  $I_C = 1.5\text{ A}$ )
- Low saturation voltage:  $V_{CE(sat)} = 1.5\text{ V}$  (max) ( $I_C = 1.5\text{ A}$ )

### Absolute Maximum Ratings ( $T_c = 25^\circ\text{C}$ )

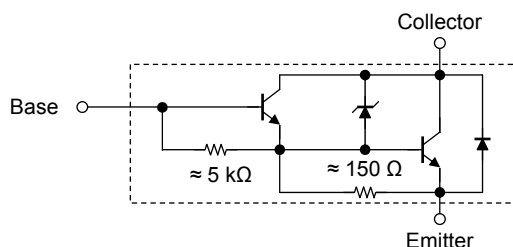
Characteristics S		ymbol	Rating	Unit
Collector-base voltage		$V_{CBO}$	$65 \pm 10$	V
Collector-emitter voltage		$V_{CEO}$	$65 \pm 10$	V
Emitter-base voltage		$V_{EBO}$	7	V
Collector current	DC I	C	4	A
	Pulse I	CP	6	
Base current		$I_B$	0.5	A
Collector power dissipation	$T_a = 25^\circ\text{C}$	PC	2.0	W
	$T_c = 25^\circ\text{C}$		25	
Junction temperature		$T_j$ 150		$^\circ\text{C}$
Storage temperature range		$T_{stg}$	-55 to 150	$^\circ\text{C}$



Weight: 1.7 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

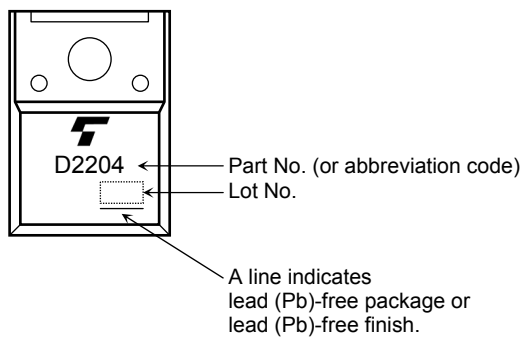
### Equivalent Circuit

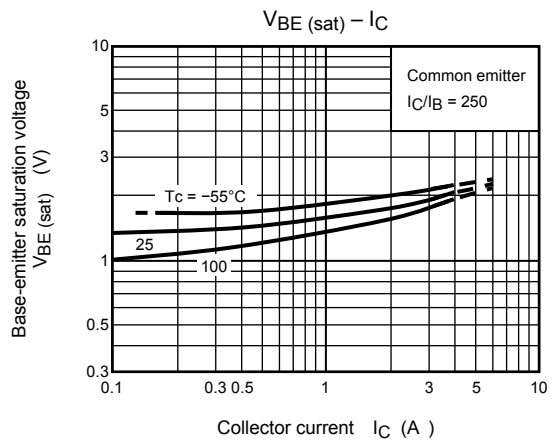
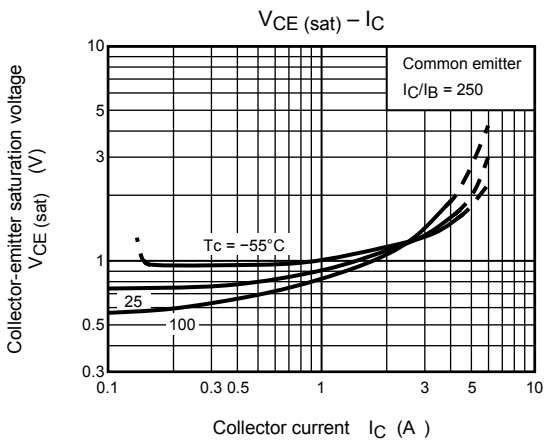
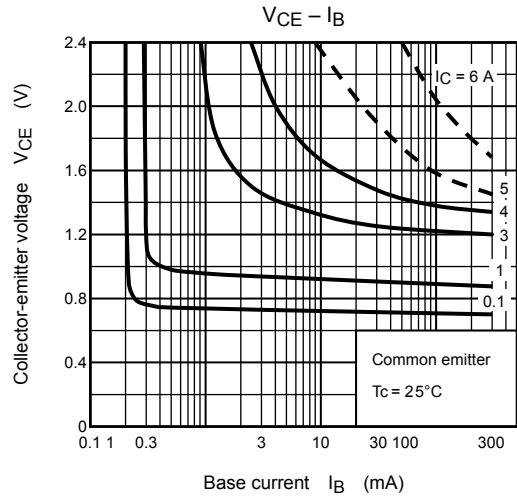
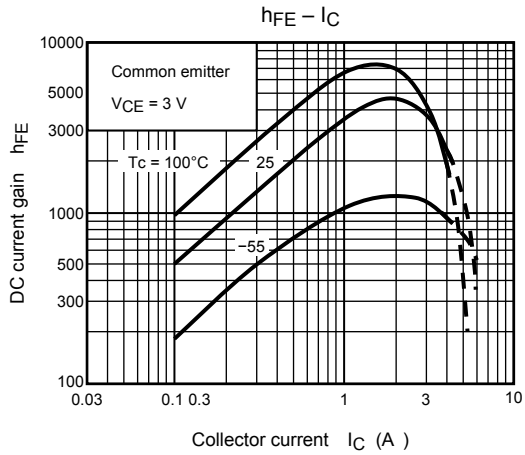
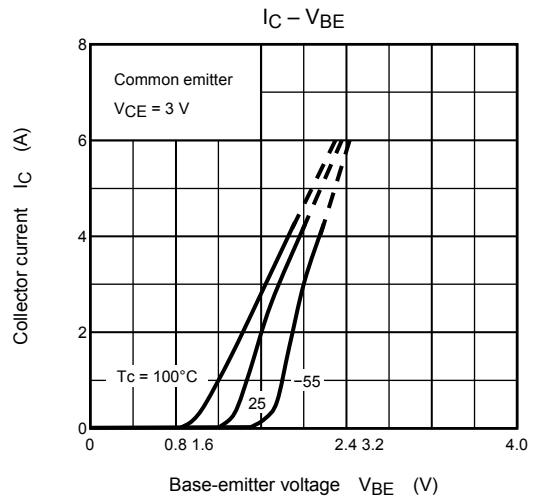
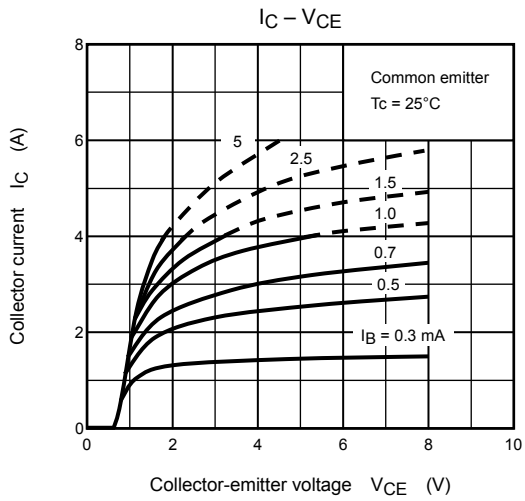


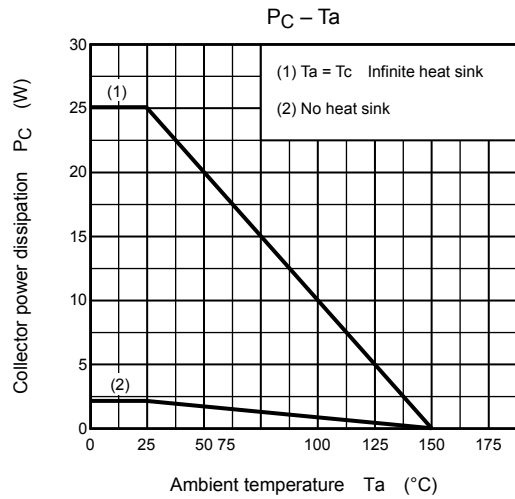
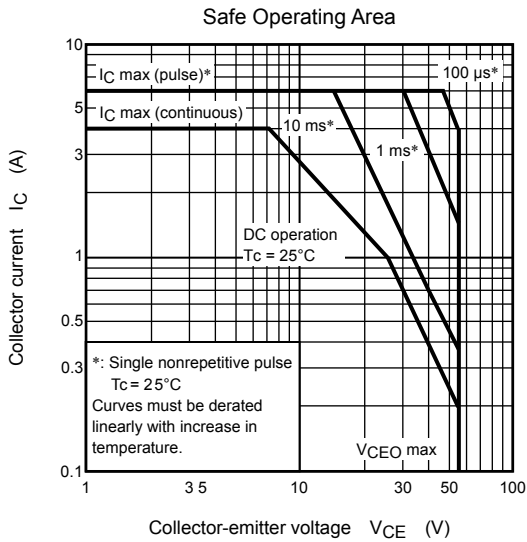
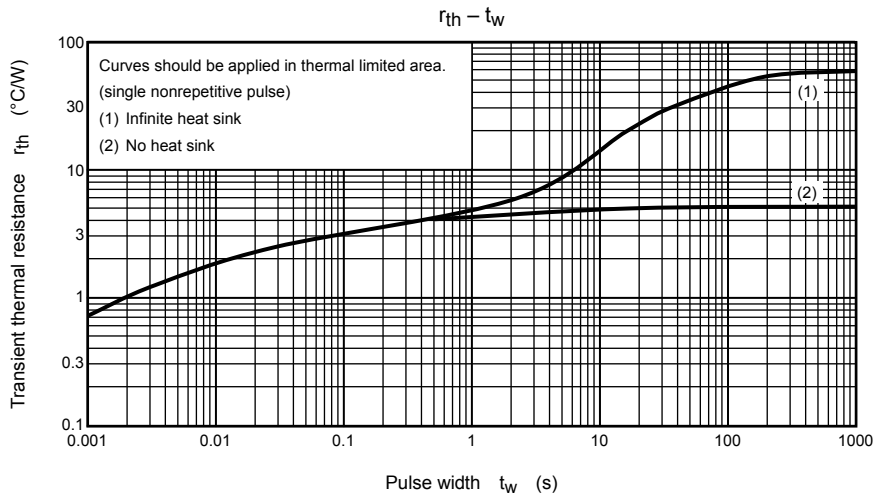
## Electrical Characteristics (Tc = 25°C)

Characteristics S		symbol	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current		$I_{CBO}$	$V_{CB} = 45 \text{ V}, I_E = 0$	—	—	100	$\mu\text{A}$
Emitter cut-off current		$I_{EBO}$	$V_{EB} = 6 \text{ V}, I_C = 0$	—	—	2.5	$\text{mA}$
Collector-emitter breakdown voltage		$V_{(BR)CEO}$	$I_C = 10 \text{ mA}, I_B = 0$	55	65	75	V
DC current gain		$h_{FE(1)}$	$V_{CE} = 3 \text{ V}, I_C = 1.5 \text{ A}$	2000	—	15000	
		$h_{FE(2)}$	$V_{CE} = 3 \text{ V}, I_C = 3 \text{ A}$	1000	—	—	
Collector-emitter saturation voltage		$V_{CE(sat)(1)}$	$I_C = 1.5 \text{ A}, I_B = 3 \text{ mA}$	—	—	1.5	V
		$V_{CE(sat)(2)}$	$I_C = 3 \text{ A}, I_B = 12 \text{ mA}$	—	—	2.0	
Base-emitter saturation voltage		$V_{BE(sat)}$	$I_C = 1.5 \text{ A}, I_B = 3 \text{ mA}$	—	—	2.0	V
Switching time	Turn-on time	$t_{on}$	<p><math>I_{B1} = -I_{B2} = 3 \text{ mA}, \text{ duty cycle } \leq 1\%</math></p>	—	1.0	—	$\mu\text{s}$
	Storage time	$t_{stg}$		—	5.0	—	
	Fall time	$t_f$		—	2.0	—	

## Marking







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